It is hereby certified that the paper ID: IJRASET10865, entitled
*A Area Efficient Thermal Aware Testing Using Scan Chain Architecture*

by
*Dr. M. Shyam Sundar*

after review is found suitable and has been published in
*Volume 5, Issue XI, November 2017*

in
*International Journal for Research in Applied Science & Engineering Technology*

Good luck for your future endeavors

Editor in Chief, iJRASET